

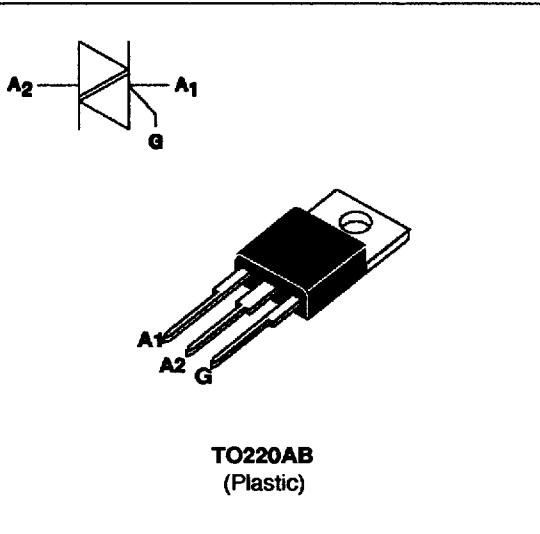
## LOGIC LEVEL TRIACS

## FEATURES

- LOW  $I_{GT}$  = 10mA max
- HIGH EFFICIENCY SWITCHING ON COMMUTATION
- BTA Family :  
INSULATING VOLTAGE = 2500V(RMS)  
(UL RECOGNIZED : E81734)

## DESCRIPTION

The BTA/BTB12 SW Triac family are high performance products glass passivated PNPN devices.  
These parts are suited for low power trigger circuit (integrated circuits, microcontroller, microprocessors).



## ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
$I_T$ (RMS)	RMS on-state current (360° conduction angle)	BTA	$T_c = 70^\circ C$	A
		BTB	$T_c = 75^\circ C$	
$I_{TSM}$	Non repetitive surge peak on-state current ( $T_j$ initial = 25°C )	$t_p = 8.3$ ms	126	A
		$t_p = 10$ ms	120	
$I_{2t}$	$I_{2t}$ value	$t_p = 10$ ms	72	A <sup>2</sup> s
$dI/dt$	Critical rate of rise of on-state current Gate supply : $I_G = 50$ mA $dI_G/dt = 0.1$ A/ $\mu$ s	Repetitive $F = 50$ Hz	20	$A/\mu s$
		Non Repetitive	100	
$T_{stg}$ $T_j$	Storage and operating junction temperature range	- 40 to + 150 - 40 to + 110	$^\circ C$ $^\circ C$	
$T_l$	Maximum lead temperature for soldering during 10 s at 4.5 mm from case	260	$^\circ C$	

Symbol	Parameter	BTA / BTB12-			Unit
		400 SW	600 SW	700 SW	
$V_{DRM}$ $V_{RRM}$	Repetitive peak off-state voltage $T_j = 110^\circ C$	400	600	700	V

## THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
R <sub>th</sub> (j-a)	Junction to ambient	60	°C/W
R <sub>th</sub> (j-c) DC	Junction to case for DC	BTA	3.3
		BTB	2.7
R <sub>th</sub> (j-c) AC	Junction to case for 360° conduction angle (F = 50 Hz)	BTA	2.5
		BTB	2

## GATE CHARACTERISTICS (maximum values)

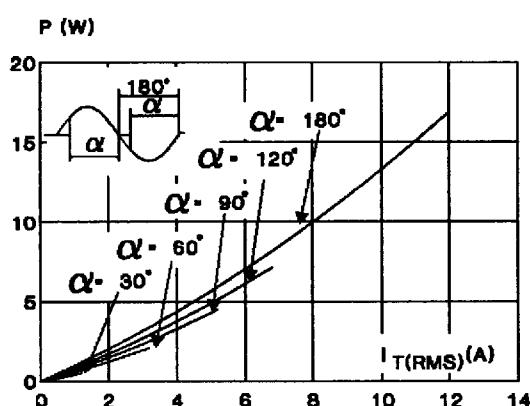
P<sub>G</sub> (AV) = 1W    P<sub>GM</sub> = 10W (t<sub>p</sub> = 20 μs)    I<sub>GM</sub> = 4A (t<sub>p</sub> = 20 μs)    V<sub>GM</sub> = 16V (t<sub>p</sub> = 20 μs).

## ELECTRICAL CHARACTERISTICS

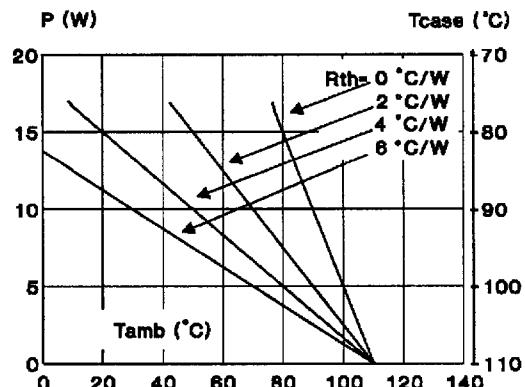
Symbol	Test Conditions	Quadrant		Suffix	Unit
				SW	
I <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> =25°C	I-II-III	MAX	10 mA
V <sub>GT</sub>	V <sub>D</sub> =12V (DC) R <sub>L</sub> =33Ω	T <sub>j</sub> =25°C	I-II-III	MAX	1.5 V
V <sub>GD</sub>	V <sub>D</sub> =V <sub>DRM</sub> R <sub>L</sub> =3.3kΩ	T <sub>j</sub> =110°C	I-II-III	MIN	0.2 V
t <sub>gt</sub>	V <sub>D</sub> =V <sub>DRM</sub> I <sub>G</sub> = 40mA dI <sub>G</sub> /dt = 0.5A/μs	T <sub>j</sub> =25°C	I-II-III	TYP	2 μs
I <sub>L</sub>	I <sub>G</sub> =1.2 I <sub>GT</sub>	T <sub>j</sub> =25°C	I-III	TYP	15 mA
			II		25
I <sub>H</sub> *	I <sub>T</sub> = 100mA gate open	T <sub>j</sub> =25°C		MAX	25 mA
V <sub>TM</sub> *	I <sub>TM</sub> = 17A t <sub>p</sub> = 380μs	T <sub>j</sub> =25°C		MAX	1.75 V
I <sub>DRM</sub> I <sub>RRM</sub>	V <sub>DRM</sub> Rated V <sub>RRM</sub> Rated	T <sub>j</sub> =25°C		MAX	0.01 mA
		T <sub>j</sub> =110°C		MAX	1
dV/dt *	Linear slope up to V <sub>D</sub> =67%V <sub>DRM</sub> gate open	T <sub>j</sub> =110°C		MIN	50 V/μs
(dI/dt) <sub>C</sub> *	dI/dt= 0.1V/μs	T <sub>j</sub> =110°C		MIN	5.3 A/ms
	dI/dt= 20V/μs			MIN	3.5

\* For either polarity of electrode A<sub>2</sub> voltage with reference to electrode A<sub>1</sub>.

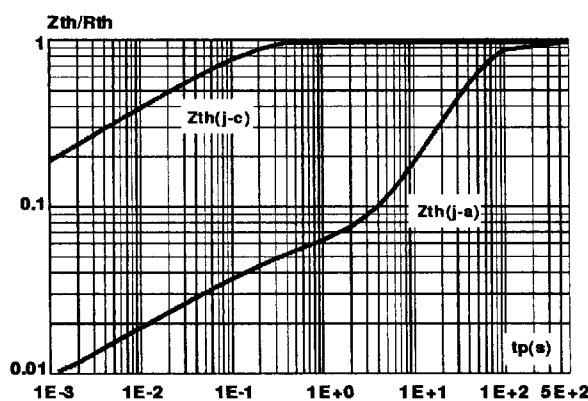
**Fig.1** : Maximum RMS power dissipation versus RMS on-state current ( $F=50\text{Hz}$ ).  
(Curves are cut off by  $(di/dt)c$  limitation)



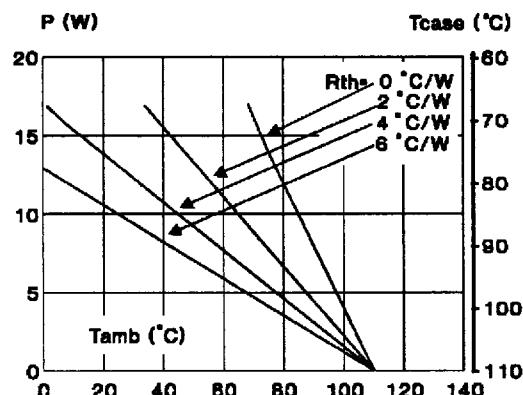
**Fig.3** : Correlation between maximum RMS power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (BTB).



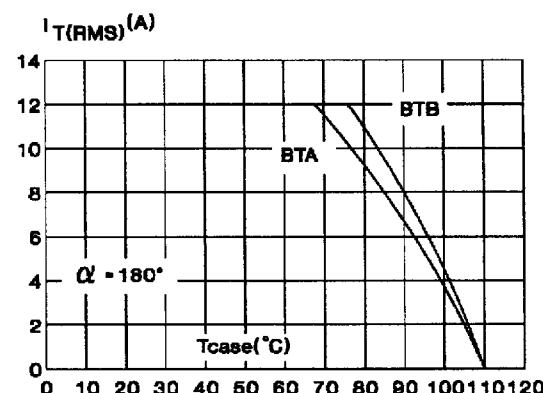
**Fig.5** : Relative variation of thermal impedance versus pulse duration.



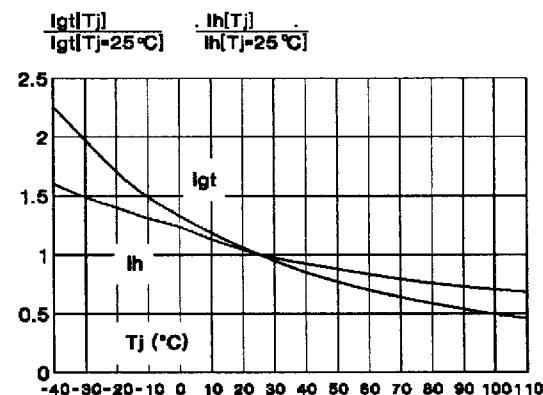
**Fig.2** : Correlation between maximum RMS power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (BTA).



**Fig.4** : RMS on-state current versus case temperature.

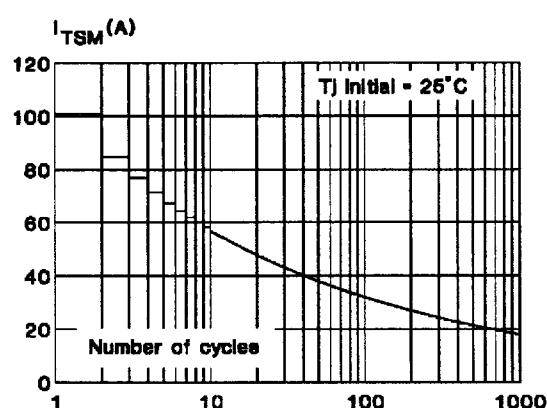


**Fig.6** : Relative variation of gate trigger current and holding current versus junction temperature.

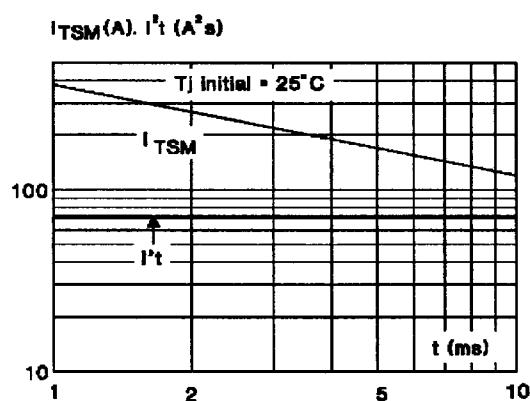


## BTA12 SW / BTB12 SW

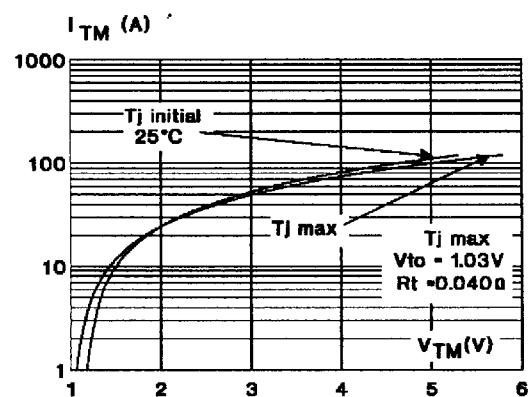
**Fig.7** : Non Repetitive surge peak on-state current versus number of cycles.



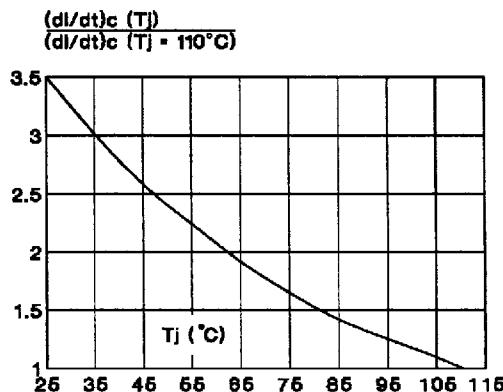
**Fig.8** : Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \leq 10\text{ms}$ , and corresponding value of  $I^2t$ .



**Fig.9** : On-state characteristics (maximum values).

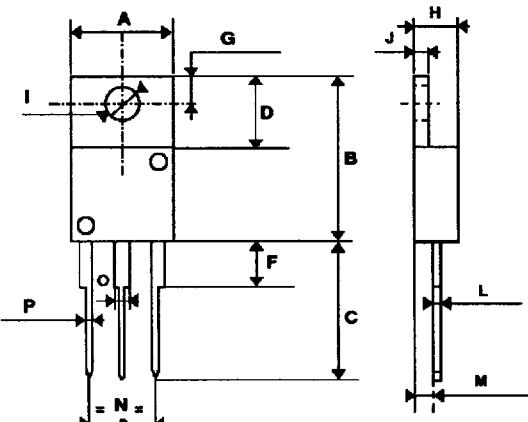


**Fig.10** : Relative variation of  $(dI/dt)_c(T)$  versus junction temperature.



## PACKAGE MECHANICAL DATA

TO220AB Plastic



REF.	DIMENSIONS			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	10.20	10.50	0.401	0.413
B	14.23	15.87	0.560	0.625
C	12.70	14.70	0.500	0.579
D	5.85	6.85	0.230	0.270
F		4.50		0.178
G	2.54	3.00	0.100	0.119
H	4.48	4.82	0.176	0.190
I	3.55	4.00	0.140	0.158
J	1.15	1.39	0.045	0.055
L	0.35	0.65	0.013	0.026
M	2.10	2.70	0.082	0.107
N	4.58	5.58	0.18	0.22
O	0.80	1.20	0.031	0.048
P	0.64	0.96	0.025	0.038

Cooling method : C

Marking : type number

Weight : 2.3 g

Recommended torque value : 0.8 m.N.

Maximum torque value : 1 m.N.

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